

## 19074 PAN File Report: Panasonic VBHN325SA 16 Module

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### **1** Project Summary

CFV Solar conducted PAN file testing on one **VBHN325SA 16** module produced by **Panasonic**. I-V curves at multiple irradiance and temperature conditions were obtained on one sample per IEC 61853-1:2011. The PVsyst 6 single-diode model coefficients were derived with PANOpt<sup>®</sup>, a software developed at CFV.

### 2 Executive Summary of Results

The performance matrix data were scaled to prepare PAN file source data for the 325 W power class of the VBHN325SA 16 type. The "Measured STC" scaling method (explained in Procedures section) was used. Optimized PAN files were created for the specified module type and power class with PANOpt<sup>®</sup>, CFV's proprietary software.

## **TESTING - CERTIFICATION - INNOVATION**

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### 3 Sample Information

Other samples were also tested as part of project 19074. For full information on all samples, refer to reports 19074-PR-E-002 through 19074-PR-E-009.

#### Labeling

Module ID	SNL ID	Manufacturer	Module Type	Serial Number
19074-001	00003852	Panasonic	VBHN325SA 16	W0JH9NH02089

#### **Constructional Details**

Module Type	Length [m]	Width [m]	Thickness [mm]
VBHN325SA 16	1.590	1.053	35

#### **Nameplate Values**

Module Type	Isc [A]	Voc [V]	Imp [A]	Vmp [V]	Pmp [W]	Max Sys Volt [V]	Fuse Rating [A]
VBHN325SA 16	6.03	69.6	5.65	57.6	325	600	15

#### **Photographs**







### Nameplate(s)



#### Sampling

A single fielded sample of the type, VBHN325SA 16, was tested for this project and used in the PAN file creation.



## 4 Procedures

There were other tests included in project 19074. This report includes only the procedures relevant to the PAN file generation and Electroluminescence Imaging.

### 4.1 Electroluminescence Imaging

Electroluminescence (EL) images were taken with a Peltier-cooled CCD camera that has a resolution of 8.3 MPixels. A long pass filter blocked incoming light with wavelength below 850 nm. A constant DC bias was applied to the modules while the imaging was performed in the dark.

A relevant IEC document (IEC TS 60904-13:2018) has been published recently. The EL imaging was carried out at 1.0x Isc per a procedure in this document, but this test is not yet included in CFV's scope of ISO 17025 accreditation.

## 4.2 Preconditioning

The sample was installed outdoors on a fixed rack in open circuit to receive a minimum of 40 kWh/m<sup>2</sup> of irradiation. The plane-of-array irradiance was measured with a calibrated pyranometer. CFV is ISO 17025-accredited to carry out Preconditioning per IEC 61215:2005. The preconditioning carried out for this project deviated from IEC 61215:2005 in that a higher irradiation dose was received (IEC 61215:2005 specifies a dose of 5.0 to 5.5 kWh/m<sup>2</sup>).

## 4.3 MQT 06.1 Performance at STC

Performance at STC test was carried out in conformity with IEC 61215-2:2016 MQT 06.1. CFV is ISO 17025-accredited to carry out the test. This test also qualifies as MQT 02 Maximum Power Determination.

We used a pulse-type solar simulator (Halm moduleTest 3; Fig. 4.3.1), classified as class AAA per IEC 60904-9:2007. The irradiance of the Xenon arc lamp flash at the module plane was measured with a co-planar reference cell (Fraunhofer WPVS type, manufactured by Czibula & Grundmann GmbH) that meets the requirements of IEC 60904-2:2015. The reference cell was calibrated at PTB of Germany. The solar simulator was in a room constantly maintained at  $25 \pm 1^{\circ}$ C, and prior to the tests we waited for the modules to thermally stabilize to the room temperature. During the test, the module backside temperature was measured at four points with calibrated RTDs with accuracy better than  $\pm 0.2^{\circ}$ C.

The reported I-V characteristics show the average of three consecutive measurements. Each measurement was carried out in conformity with IEC 60904-1:2006. One measurement involved a forward sweep (Isc to Voc) and a reverse sweep (Voc to Isc), whose I-V data were averaged to calculate the Isc, Voc, Imp, and Vmp values. The irradiance was controlled to be within  $1000 \pm 3 \text{ W/m}^2$  for the measurements. The minimal differences between the STC and the actual test conditions were further corrected per IEC 60891:2009.





Prior to measurements, testing was carried out to check for I-V curve hysteresis between the forward and reverse sweeps. It was found that the VBHN325SA 16 module type needed three sections for both the forward and reverse sweeps. The effective sweep time for the measurements on the VBHN325SA 16 module type was 75 ms forward and 75 ms reverse.

A spectral mismatch factor of 1.0 was used as no EQE data was available for this module type.



Fig. 4.3.1 Class AAA solar simulator from h.a.l.m. used at CFV

Table 4.3.1 shows the uncertainty and repeatability of CFV's STC performance data. The values take in to account all the major sources of error, including the reference cell calibration, spectrum of the flasher, non-uniformity of the irradiance in the test plane, etc. CFV maintains a rigorous daily, weekly, and quarterly quality control program to guarantee top-tier flash measurement accuracy. The quarterly control modules are also measured annually at Fraunhofer ISE CalLab of Germany.

### 4.4 Performance Matrix

Multi-irradiance and multi-temperature Performance Matrix test was conducted in conformity with IEC 61853-1:2011 § 8.1. CFV is ISO 17025-accredited to carry out this test.

The test points cover irradiances from 100 to  $1100 \text{ W/m}^2$ , and temperatures from 15 to 75°C. In addition to the test points defined in IEC 61853-1:2011 § 8.1, measurements were obtained at five additional points, as shown in Table 4.4.1. The irradiance was varied by adjusting the voltage applied to the Xenon arc lamp. The spectral match remains class A or



better for all irradiances. An integrated thermal chamber varied the module temperature with a laminar air flow, and the module temperature was monitored at 4 points with calibrated RTDs having uncertainties of  $\pm$  0.13°C. For each measurement, the max-min temperature spread was less than 1.5°C.

The monitor cell was mounted at a location outside the thermal chamber and was not coplanar with the test module. The monitor cell sensitivity was adjusted to reproduce the Pmp measured at STC on the test module. Other than the irradiance and temperature controls, the measurement procedure was identical to the Performance at STC test.

Irradiance						
(W/m²)	15°C	25°C	50°C	75°C		
1100		$\odot$	$\odot$	$\odot$		
1000	Θ	$\odot$	Θ	$\odot$		
800	Θ	$\odot$	$\odot$	$\odot$		
600	Θ	$\odot$	$\odot$	$\odot$		
400	Θ	$\odot$	Θ	$\otimes$		
200	Ο	$\odot$	$\otimes$	$\otimes$		
100	$\odot$	$\odot$	$\otimes$	$\otimes$		

Table 4.4.1: Test points for the performance matrix. 5 additional test points are indicated.

 $\odot$  Measured and required by the IEC 61853-1 standard

& Additional test points; Measured but not required by the IEC 61853-1 standard



### 4.5 MQT 04 Temperature Coefficients

Temperature Coefficients test was conducted in conformity with IEC 61215-2:2016 MQT 04 and IEC 60891:2009 § 4. CFV Solar is ISO 17025-accredited to carry out the test.

The test was carried out along with the Performance Matrix test. In addition to the 15, 25, 50, and 75°C temperatures required for the matrix, the modules were flashed with 1000 W/m<sup>2</sup> irradiance at additional intermediate temperatures. The temperature coefficients for Isc, Voc, Imp, Vmp, and Pmp were determined by linear regression over the 15-75°C temperature range.

### 4.6 Performance Data Scaling

When creating PAN files for PVsyst, one requirement is that the Pmp at STC needs to match the nameplate power. This requirement translates into the technical issues of (1) how to scale the Pmp values at the various temperature and irradiance points and (2) how to scale the STC Isc, Voc, Imp, and Vmp values, if the measured values at STC do not match the nameplate values.

In this project, we scaled the performance matrix data for use with PANOpt®, by the following approach:

Ртр	A constant gain factor was applied to the Pmp values in the matrix, to obtain the nameplate rating at STC. The gain factor used was: [Pmp Gain] = [NP Pmp]/[Measured STC Pmp]
Isc, Voc, Imp, Vmp	A constant gain factor equal to the square root of [Pmp Gain] was applied to the Isc, Voc, Imp, and Vmp values. [Isc Gain] = [Voc Gain] = [Imp Gain] = [Vmp Gain] = [Pmp Gain] <sup>1/2</sup>

Measured STC Approach

### 4.7 PAN file Generation and Optimization

Optimized PAN files were prepared using PANOpt®, an in-house-developed software for deriving from the test data optimum solutions for the PVsyst 6 single-diode performance model. Starting with the measured values of Isc, Voc, Imp, Vmp, muIsc, and an Rs value calculated from the I-V curves with the Swanson method, the PANOpt® solver iterated over a given parameter space for Rs, Rsh, RshG0 (and di<sup>2</sup>/ $\mu$ t<sub>eff</sub> for thin-film technologies) until the PVsyst 6 model-predicted Pmp values over the Performance Matrix points matched the measured values (average of three samples) with minimum error.

The IAM profile of the test module was not experimentally determined. The default PVsyst IAM profile for normal glass was adopted.



### **5** Results

### 5.1 Electroluminescence Imaging

The module was imaged in the dark while a constant DC bias current of 6.03 A (Isc) was applied to the module.



### 5.2 Preconditioning

The module received 41.33 kWh/m2 of outdoor preconditioning prior to indoor performance testing. The preconditioning was performed with the module in open circuit.





### 5.3 MQT 06.1 Performance at STC

The following values were measured after preconditioning and during the Performance Matrix test.

Module II	Isc [A]	Voc [V]	Imp [V]	Vmp [V]	Pmp [W]	FF [%]
19074-00	L 5.903	70.21	5.506	58.54	322.30	77.76

Table 5.3.1 Uncertainty and repeatability of flash measurements on Si modules

	Isc	Voc	Imp	Vmp	Pmp
Uncertainty	± 1.8 %	± 0.7 %	± 2.2 %	± 1.3 %	± 2.2 %
Repeatability	± 0.20 %	± 0.20 %	± 0.30 %	± 0.40 %	± 0.45 %

### 5.4 MQT 04 Temperature Coefficients

#### **Relative Units**

Module ID	α Isc [%/°C]	β Voc [%/°C]	α Imp [%/°C]	β Vmp [%/°C]	δ Pmp [%/°C]
19074-001	+0.0264	-0.2421	-0.0037	-0.2931	-0.2962

### **Absolute Units**

Module ID	α Isc [A/°C]	β Voc [V/°C]	α Imp [A/°C]	β Vmp [V/°C]	δ Pmp [W/°C]
19074-001	+0.00156	-0.1699	-0.00021	-0.1715	-0.9551

Table 5.4.1 Estimated uncertainty of temperature coefficients (relative)

	α Isc	β Voc	α Imp	βVmp	γ Pmp
Uncertainty (k = 2)	± 10 %	±5%	N/A	N/A	±5%

Plots





### **Measured Data**

The following table shows the I-V values measured on the tested sample.

Module ID	T (°C)	G (W/m2)	Isc (A)	Voc (V)	Imp (A)	Vmp (V)	Pmp (W)
19074-001	14.97	1000	5.891	71.86	5.503	60.13	330.88
19074-001	19.92	1000	5.897	71.04	5.508	59.34	326.83
19074-001	24.91	1000	5.903	70.23	5.506	58.55	322.36
19074-001	29.79	1000	5.917	69.39	5.513	57.75	318.35
19074-001	34.72	1000	5.925	68.56	5.516	56.89	313.81
19074-001	39.66	1000	5.933	67.74	5.510	56.08	309.00
19074-001	44.71	1000	5.944	66.88	5.509	55.24	304.32
19074-001	49.87	1000	5.944	66.01	5.511	54.26	299.04
19074-001	54.69	1000	5.955	65.18	5.511	53.45	294.59
19074-001	59.63	1000	5.965	64.32	5.498	52.66	289.50
19074-001	64.62	1000	5.970	63.46	5.489	51.82	284.42
19074-001	69.58	1000	5.976	62.60	5.500	50.78	279.29
19074-001	74.97	1000	5.976	61.68	5.493	49.82	273.67



### 5.5 Performance Matrix

### **Efficiency Curves**

In the following plot, circles indicate the average of three measurements at each irradiance and temperature test condition. Bars inside the circles indicate the values from each of the three measurements.



### **Measured Data**

The following table shows the Performance Matrix data measured on the tested sample.

	Č						
Module ID	T (°C)	G (W/m2)	Isc (A)	Voc (V)	Imp (A)	Vmp (V)	Pmp (W)
19074-001	15	100	0.595	65.78	0.543	55.56	30.16
19074-001	15	200	1.183	67.79	1.093	57.70	63.06
19074-001	15	400	2.354	69.65	2.185	59.42	129.85
19074-001	15	600	3.532	70.65	3.292	60.06	197.74
19074-001	15	800	4.706	71.35	4.398	60.21	264.83
19074-001	15	1000	5.891	71.85	5.503	60.12	330.86
19074-001	25	100	0.599	63.95	0.547	53.47	29.25
19074-001	25	200	1.183	66.01	1.090	56.07	61.14
19074-001	25	400	2.365	67.92	2.190	57.75	126.45
19074-001	25	600	3.542	68.96	3.298	58.31	192.28
19074-001	25	800	4.718	69.68	4.400	58.54	257.56
19074-001	25	1000	5.903	70.21	5.506	58.54	322.30
19074-001	25	1100	6.488	70.44	6.055	58.49	354.17
19074-001	50	100	0.602	59.36	0.541	49.64	26.85



Module ID	T (°C)	G (W/m2)	Isc (A)	Voc (V)	Imp (A)	Vmp (V)	Pmp (W)
19074-001	50	200	1.199	61.52	1.096	51.75	56.70
19074-001	50	400	2.379	63.56	2.214	52.88	117.06
19074-001	50	600	3.567	64.66	3.302	53.89	177.96
19074-001	50	800	4.754	65.43	4.399	54.25	238.63
19074-001	50	1000	5.944	65.99	5.511	54.25	298.95
19074-001	50	1100	6.528	66.24	6.061	54.18	328.41
19074-001	75	100	0.606	54.60	0.543	44.32	24.07
19074-001	75	200	1.207	56.92	1.086	47.06	51.10
19074-001	75	400	2.399	59.07	2.188	48.70	106.55
19074-001	75	600	3.593	60.25	3.298	49.42	162.97
19074-001	75	800	4.784	61.05	4.386	49.84	218.58
19074-001	75	1000	5.976	61.67	5.493	49.82	273.65
19074-001	75	1100	6.578	61.92	6.031	49.91	301.01

### 5.6 Performance Matrix Data Scaling

The gain factors were calculated as explained in the procedures section.

Measured STC values of the single test module

Measured Power Class	Measured STC Isc (A)	Measured STC Voc (V)	Measured STC Imp (A)	Measured STC Vmp (V)	Measured STC Pmp (W)
325	5.903	70.21	5.506	58.54	322.30

Applied gain factors for PAN file STC values by power class

PAN File Power Class	Isc Gain	Voc Gain	Imp Gain	Vmp Gain	Pmp Gain
325	1.0042	1.0042	1.0042	1.0042	1.0084

PAN file STC values by power class

| PAN File    |
|-------------|-------------|-------------|-------------|-------------|
| Power Class | STC Isc (A) | STC Voc (V) | STC Imp (A) | STC Vmp (V) |
| 325         | 5.927       | 70.51       | 5.529       | 58.78       |



### 5.7 PAN file Generation and Optimization

#### **PAN File Parameters for 325 W Class**

Tab	Parameter	325 W		
Basic data	Model	VBHN325SA 16		
	Manufacturer	Panasonic		
	File name	Panasonic_VBHN325SA 16_Dec2019_CFV.PAN		
	Data source	CFV Solar Test Lab - Tested Class		
	Nom. Power (Wp)	325		
	Tol (%)	0		
	Tol. + (%)	10		
	Technology	Si-mono		
	GRef (W/m2)	1000		
	TRef (°C)	25		
	Isc (A)	5.927		
	Voc (V)	70.51		
	Impp (A)	5.529		
	Vmpp (V)	58.78		
	mulsc (%/°C)	0.026		
Sizes and	Length (mm)	1590		
Technology	Width (mm)	1053		
	Thickness (mm)	35		
	Cells in series	96		
	Maximum voltage IEC (V)	600		
	Maximum voltage UL (V)	600		
	Nb. of sub-modules	4		
	Sub-module partition	Full Cells		
Model	Rsh (Ohm)	1144		
parameters	Rs (Ohm)			
/		0.600		
Rshunt -		0.000		
Rserie				
Model	Rshunt at Ginc = 0 (Ohm)	3850		
parameters	Exponential parameter			
/ RShunt		5.5		
expon.				
Model	Apply Temperature Correction	Checked		
parameters	on Gamma			
/ Temper. coeff	Pmpp temper. Coeff <sup>1</sup>	-0.297		
Additional data /	Special IAM defined for this module	Unchecked		

<sup>&</sup>lt;sup>1</sup> The Pmp temperature coefficient in PVsyst is different from the definition in IEC 60891:2009. In PVsyst, the Pmp temperature coefficient is calculated from the Pmp values at 25°C and 45°C. Per IEC 60891:2009, the Pmp temperature coefficient is to be calculated by a linear fit through Pmp values measured over a temperature range greater than or equal to 30°C. There is in fact some nonlinearity in the Pmp dependence on temperature, which is why the Pmp temperature coefficient value for the PAN file is different from the value reported in Section 04.



Tab	Paramete	er	325 W
Customized	Front Surf	ace	Normal Glass
IAM	Point 1	0°	1.000
	Point 2	30°	0.998
	Point 3	50°	0.981
	Point 4	60°	0.948
	Point 5	70°	0.862
	Point 6	75°	0.776
	Point 7	80°	0.636
	Point 8	85°	0.403
	Point 9	90°	0.000

### **PAN File Model Accuracy**

PVsyst 6 model output was compared with the scaled data used as the PANOpt® input.

Power	RMS Error of Pmp (Error = PVsyst 6 model Pmp - Measured Pmp) [W]						RMS Error of Pmp (Error = PVsyst 6 model Pmp – Measured Pmp)				
Class	15-75°C	15°C	25°C	50°C	75°C						
280 W	0.05	0.05	0.05	0.04	0.04						

Module	RMS Error of Eff. (Error = PVsyst 6 model Eff. – Measured Eff.) [%p]					
Туре	15-75°C	15°C	25°C	50°C	75°C	
280 W	0.004	0.004	0.004	0.003	0.002	



--END OF REPORT--



## **CFV Labs**